

Notice of References Cited

Application/Control No.

10/800,827

Applicant(s)/Patent Under
Reexamination
CHEN ET AL.

Examiner

Kezhen Shen

Art Unit

2609

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0088440 A1	05-2004	Chen et al.	710/001
*	B	US-2005/0050100 A1	03-2005	Chin, Yuan-Chang	707/104.1
*	C	US-2004/0252967 A1	12-2004	Sheu et al.	386/046
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	T					

NON-PATENT DOCUMENTS

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	V	
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